

Product Summary

V_{RRM}	1200 V
I_F ($T_c=150^\circ\text{C}$)	10 A
Q_c	51 nC

Features

- Extremely low reverse current
- No reverse recovery current
- Temperature independent switching
- Positive temperature coefficient on V_F
- Excellent surge current capability
- Low capacitive charge

Benefits

- Essentially no switching losses
- System efficiency improvement over Si diodes
- Increased power density
- Enabling higher switching frequency
- Reduction of heat sink requirements
- System cost savings due to smaller magnetics
- Reduced EMI

Applications

- Switch mode power supplies (SMPS)
- Uninterruptible power supplies
- Motor drivers
- Power factor correction

Package Pin Definitions

- Pin1 and backside - Cathode
- Pin2- Anode

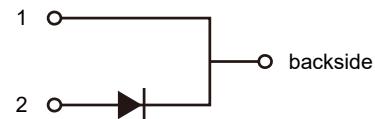
Package Parameters

Part Number	Marking	Package
B2D10120H1	B2D10120H1	TO-247-2

Package: TO-247-2



Electrical Connection



Maximum Ratings ($T_c=25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Test conditions	Value	Unit
V_{RRM}	Repetitive peak reverse voltage		1200	V
V_{RSM}	Non-repetitive peak reverse voltage		1200	V
E_{AS}	Single pulse avalanche energy	$T_c=25^\circ\text{C}$, $L=1\text{mH}$, $I_{AS}=11\text{A}$, $V=140\text{V}$	61	mJ
I_F	Continuous forward current	$T_c=25^\circ\text{C}$ $T_c=150^\circ\text{C}$	30 10	A
I_{FSM}	Non-repetitive forward surge current	$T_c=25^\circ\text{C}$, $t_p=10\text{ms}$, Half sine wave	90	A
I_{FRM}	Repetitive forward surge current	$T_c=25^\circ\text{C}$, $t_p=10\text{ms}$, Half sine wave	45	A
$\int i^2 dt$	$i^2 t$ value	$T_c=25^\circ\text{C}$, $t_p=10\text{ms}$	41	A^2s
P_{tot}	Power dissipation	$T_c=25^\circ\text{C}$ $T_c=110^\circ\text{C}$	143 62	W
T_j	Operating junction temperature		-55~175	$^\circ\text{C}$
T_{stg}	Storage temperature		-55~175	$^\circ\text{C}$
	TO-247 mounting torque	M3 Screw	0.7	Nm

Thermal Characteristics

Symbol	Parameter	Value			Unit
		Min.	Typ.	Max.	
$R_{th(jc)}$	Thermal resistance from junction to case		1.046		K/W

Electrical Characteristics
Static Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
V_{DC}	DC blocking voltage	$T_j=25^\circ C$	1200			V
V_F	Diode forward voltage	$I_F=10A T_j=25^\circ C$ $I_F=10A T_j=175^\circ C$		1.36 2	1.6 2.6	V
I_R	Reverse current	$V_R=1200V T_j=25^\circ C$ $V_R=1200V T_j=175^\circ C$		5 30	100 300	μA

AC Characteristics

Symbol	Parameter	Test conditions	Value			Unit
			Min.	Typ.	Max.	
Q_C	Total capacitive charge	$V_R=800V T_j=25^\circ C$ $Q_C=\int_0^{V_R} C(V)dV$		51		nC
C	Total capacitance	$V_R=1V f=1MHz$ $V_R=400V f=1MHz$ $V_R=800V f=1MHz$		576 48 36		pF
E_C	Capacitance stored energy	$V_R=800V$		26		μJ

Typical Performance

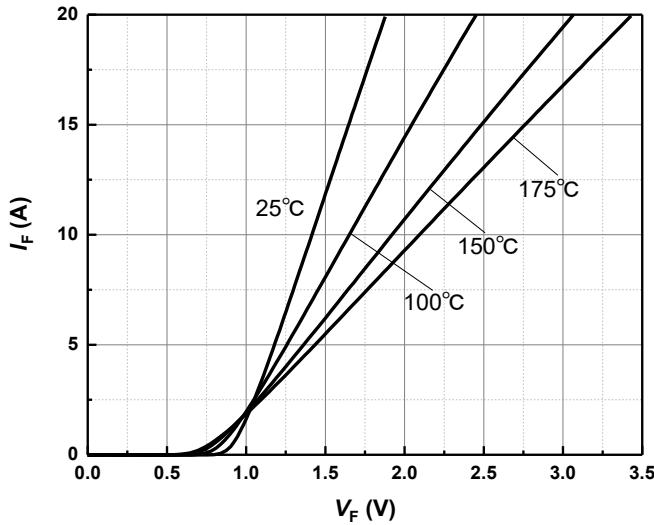


Figure 1 Typical forward characteristics

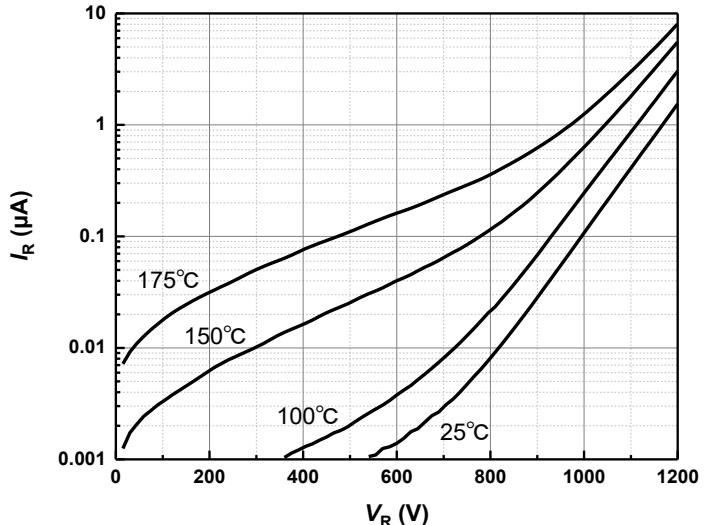


Figure 2 Typical reverse current as function of reverse voltage

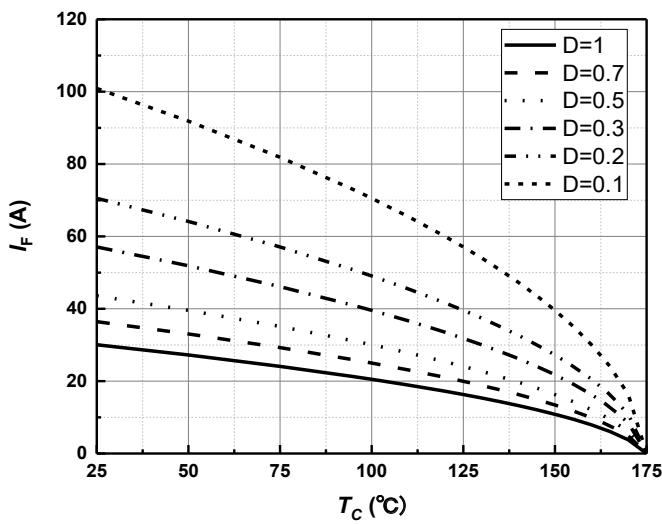


Figure 3 Diode forward current as function of temperature, D=duty cycle

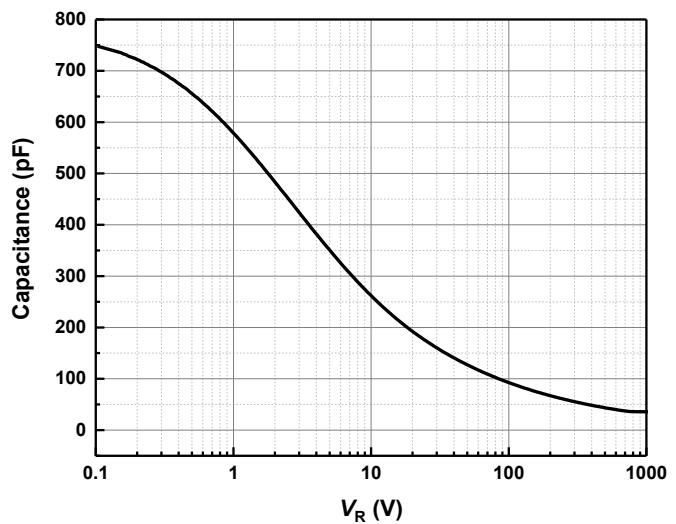


Figure 4 Typical capacitance as function of reverse voltage, $C=f(V_R)$; $T_j=25^\circ\text{C}$; $f=1 \text{ MHz}$

Typical Performance

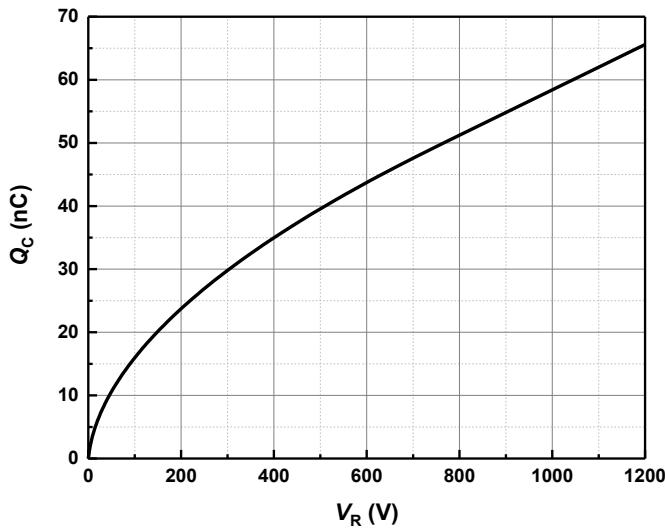


Figure 5 Typical reverse charge as function of reverse voltage

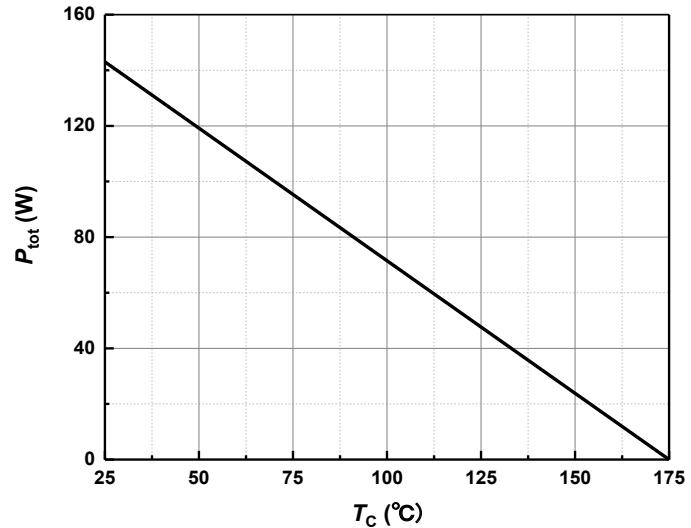


Figure 6 Power dissipation as function of case temperature

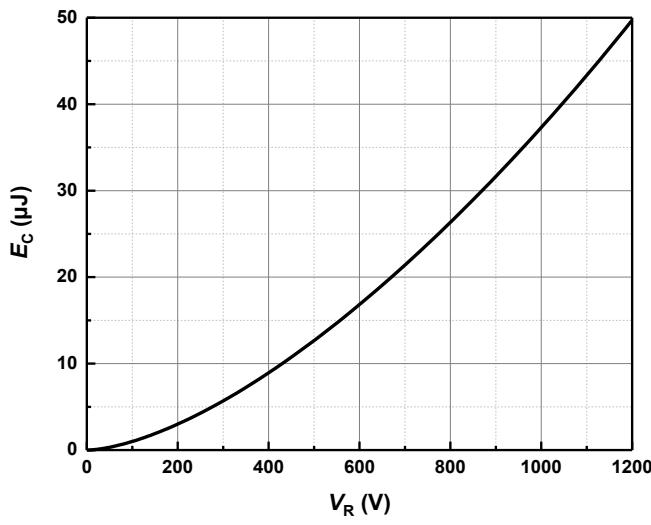


Figure 7 Capacitance stored energy

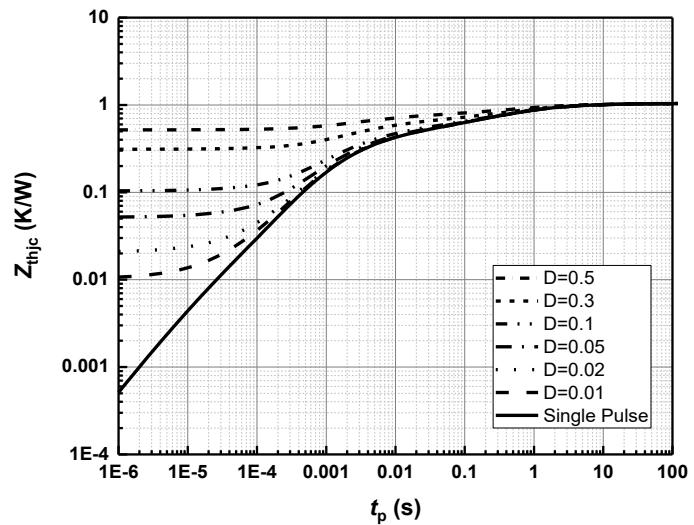
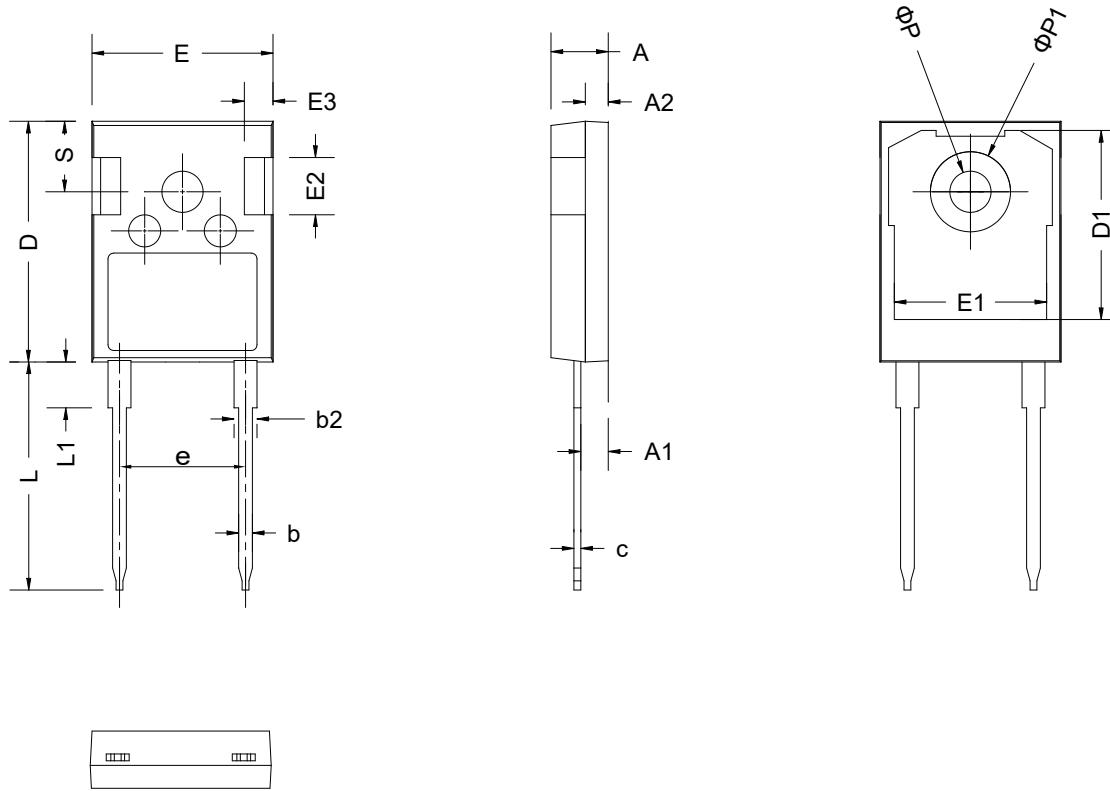


Figure 8 Max. transient thermal impedance, $Z_{thjc} = f(t)$, parameter: $D = t / T$

Package Dimensions



SYMBOL	mm		
	MIN	NOM	MAX
A	4.80	5.00	5.20
A1	2.21	2.41	2.61
A2	1.85	2.00	2.15
b	1.11	1.21	1.36
b2	1.91	2.01	2.21
c	0.51	0.61	0.75
D	20.70	21.00	21.30
D1	16.25	16.55	16.85
E	15.50	15.80	16.10
E1	13.00	13.30	13.60
E2	4.80	5.00	5.20
E3	2.30	2.50	2.70
e	10.88 BSC		
L	19.62	19.92	20.22
L1	-	-	4.30
φ P	3.40	3.60	3.80
φ P1	-	-	7.30
S	6.15 BSC		

Revision History

Document Version	Date of Release	Description of Changes
Rev 0.0	2022-03-02	Release of the datasheet.

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